TOSHIBA Field Effect Transistor Silicon P, N Channel MOS Type (U-MO V/U-MOSIV)

TPCP8404

Portable Equipment Applications Motor Drive Applications

• Low drain-source ON-resistance : P Channel RDS (ON) = 38 mQ(typ.) (VGS=-10V)

N Channel RDS (ON) = $38 \text{ m}\Omega(\text{typ.})$ (VGS=10V)

• High forward transfer admittance : P Channel $|Y_{fs}| = 7.3 \text{ S (typ.)}$ N Channel $|Y_{fs}| = 8 \text{ S (typ.)}$

• Low leakage current : P Channel IDSS = $-10 \mu A \text{ (max) (VDS = } -30 \text{ V)}$ N Channel IDSS = $10 \mu A \text{ (max) (VDS = } 30 \text{ V)}$

• Enhancement mode

: P Channel V_{th} = -0.8 to -2.0 V (V_{DS} = -10 V, I_D = -1 mA) N Channel V_{th} = 1.3 to 2.5 V (V_{DS} = 10 V, I_D = 1 mA)

Absolute Maximum Ratings (Ta = 25°C)

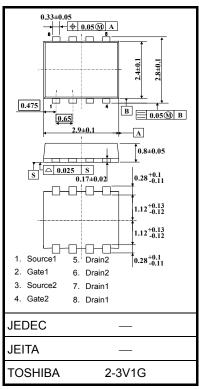
C	haracteristics	Symbol	Rating		Unit	
Drain-source	voltage	V_{DSS}	-30	30	V	
Drain-gate vo	Itage ($R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	-30	30	V	
Gate-source	voltage	V _{GSS}	±20	±20	V	
Drain	DC (Note 1)	ΙD	-4	4	Α	
current	Pulse (Note 1)	I _{DP}	-16	16	ζ.	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.48	1.48		
(t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D (2)}	1.23	1.23	W	
Drain power dissipation (t = 5 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.58	0.58	v v	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.36	0.36		
Single pulse a (Note 4)	avalanche energy	E _{AS}	2.6	2.6	mJ	
Avalanche cu	rrent	I _{AR}	-2	2	Α	
	alanche energy value at dual operation (Note 2a, 3b, 5)	E _{AR}	0.009		mJ	
Channel temp	perature	T _{ch}	150		°C	
Storage temp	erature range	T _{stg}	–55 to 150		°C	

Note: For Notes 1 to 5, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

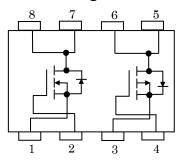
This transistor is an electrostatic-sensitive device. Handle with caution.

Unit: mm

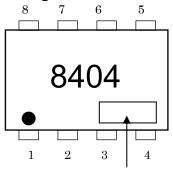


Weight: 0.017 g (typ.)

Circuit Configuration



Marking (Note 6)

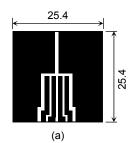


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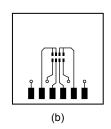
Thermal Characteristics

Charac	Symbol	Max	Unit		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	84.5	°C/W	
(t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)		101.6	O/VV	
Thermal resistance, channel to ambient	Single-device operation (Note 3a)			°C/W	
(t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	347.2	C/VV	

- Note 1: The channel temperature should not exceed 150°C during use.
- Note 2: (a) Device mounted on a glass-epoxy board (a)
- (b) Device mounted on a glass-epoxy board (b)







FR-4
$$25.4 \times 25.4 \times 0.8$$
 (Unit: mm)

- Note 3: a) The power dissipation and thermal resistance values shown are for a single device. (During single-device operation, power is only applied to one device.)
 - b) The power dissipation and thermal resistance values shown are for a single device. (During dual operation, power is evenly applied to both devices.)
- Note 4: P Channel: $V_{DD}=-24$ V, $T_{ch}=25^{\circ}$ C (initial), L=0.5 mH, $R_{G}=25$ Ω , $I_{AR}=-2$ A N Channel: $V_{DD}=24$ V, $T_{ch}=25^{\circ}$ C (initial), L=0.5 mH, $R_{G}=25$ Ω , $I_{AR}=2$ A
- Note 5: Repetitive rating: pulse width limited by maximum channel temperature
- Note 6: on the lower left of the marking indicates Pin 1.
 - Weekly code (3 digits):



Week of manufacture

(01 for the first week of the year, continuing up to 52 or 53)

2

Year of manufacture

(The last digit of the calendar year)

P-ch

Electrical Characteristics (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-off curre	ent	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-10	μА
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = -10$ mA, $V_{GS} = 0$ V	-30	_	_	V
		V _{(BR)DSX}	$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-10	_	_	·
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON	resistance	R _{DS} (ON)	$V_{GS} = -4.5 \text{ V}, I_D = -2.0 \text{ A}$		58	80	- mΩ
Dialii-source ON	resistance	NDS (ON)	$V_{GS} = -10 \text{ V}, I_D = -2.0 \text{ A}$		38	50	
Forward transfer	admittance	Y _{fS}	$V_{DS} = -10 \text{ V}, I_D = -2.0 \text{ A}$	3.7	7.3	_	S
Input capacitance	9	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz		510	_	pF
Reverse transfer	capacitance	C _{rss}			110	_	
Output capacitance		Coss		_	170	_	
	Rise time	t _r	0 V		11	_	- ns
Switching time	Turn-on time	t _{on}			20	_	
Switching time	Fall time	t _f			37	_	
	Turn-off time	t _{off}	Duty \leq 1%, $t_W = 10 \ \mu s$		99	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ -24 V, V _{GS} = -10 V,	_	13	_	nC
Gate-source charge 1		Q _{gs1}	I _D = -4 A	_	1.7	_	
Gate-drain ("miller") charge		Q _{gd}		_	4.6	_	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-16	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = -4 A, V _{GS} = 0 V	_	_	1.2	V

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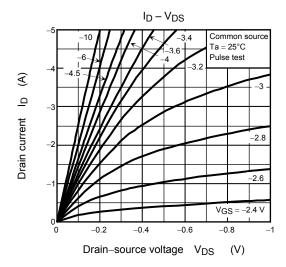
Electrical Characteristics (Ta = 25°C)

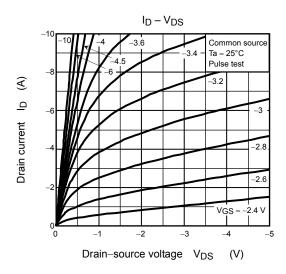
Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-off current		I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	10	μА
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_	_	\ \
		V _{(BR) DSX}	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	10	_	_	\ \ \ \ \ \
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	1.3	_	2.5	٧
Drain-source ON	rogiotanos	D= - (-)	$V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$	_	58	80	mΩ
Dialii-source ON	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 2 A	_	38	50	
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2 A	4	8	_	S
Input capacitance)	C _{iss}		_	190	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	45	_	pF
Output capacitan	ce	C _{oss}		_	60	_	
Switching time	Rise time	t _r	$V_{GS} = \frac{10 \text{ V}}{0 \text{ V}} = \frac{10 \text{ P}}{10 \text{ P}} = 2 \text{ A}$ $V_{DD} \approx 15 \text{ V}$ $V_{DD} \approx 15 \text{ V}$ $V_{DD} \approx 15 \text{ V}$	_	4.5	_	- ns
	Turn-on time	t _{on}		ı	9.0	_	
	Fall time	t _f			3.0	_	
	Turn-off time	t _{off}		_	12	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	4.6	_	
Gate-source charge 1		Q _{gs1}	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 4 \text{ A}$	_	0.7	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	1.4	_	

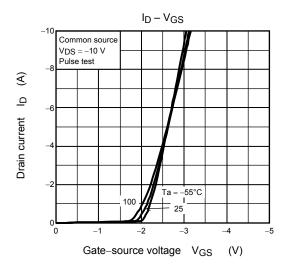
Source-Drain Ratings and Characteristics (Ta = 25°C)

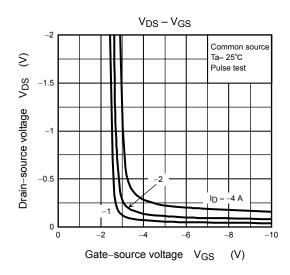
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	16	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = 4 A, V _{GS} = 0 V	_	_	-1.2	V

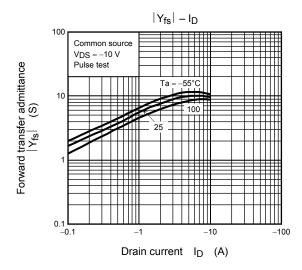
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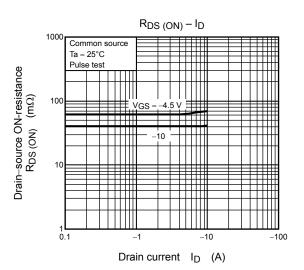




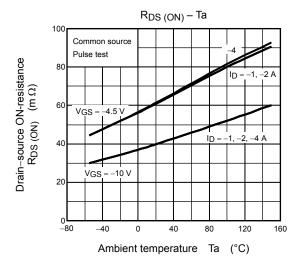


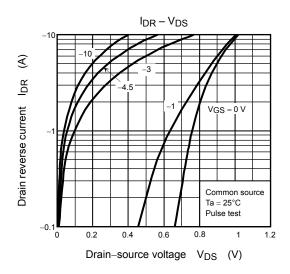


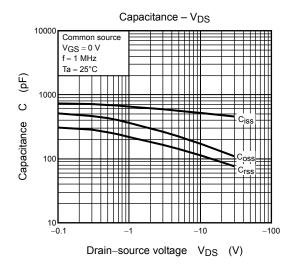


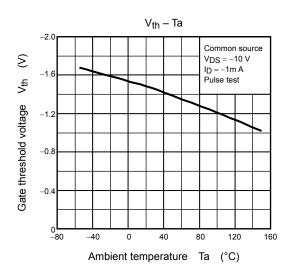


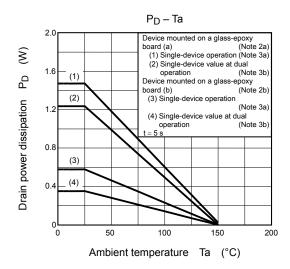
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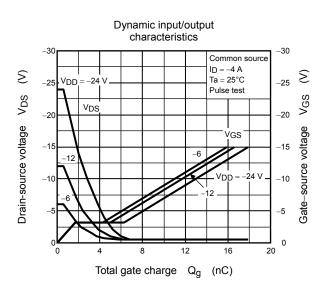




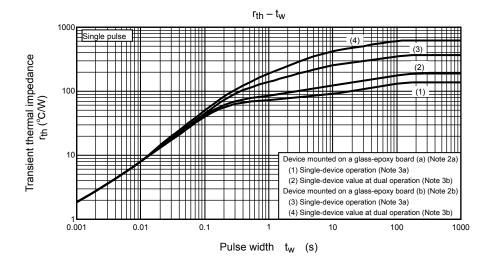


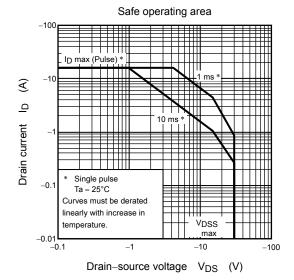




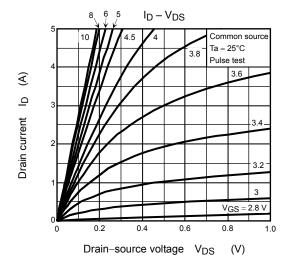


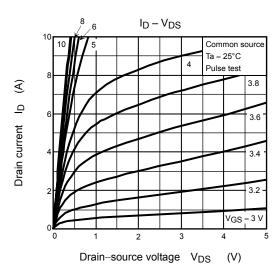
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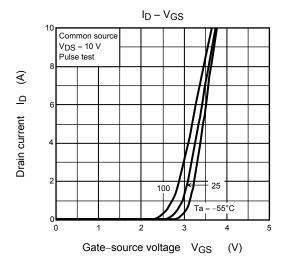


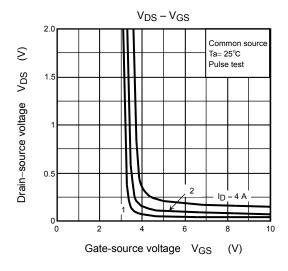


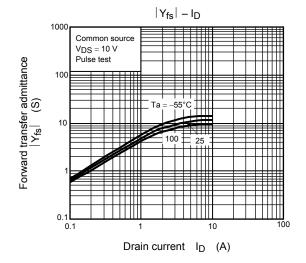
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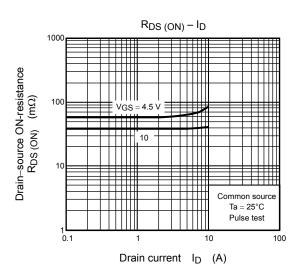


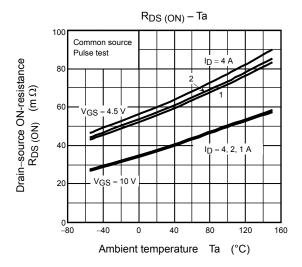


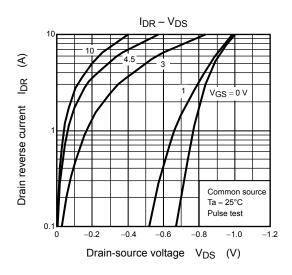


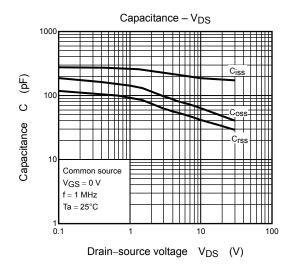


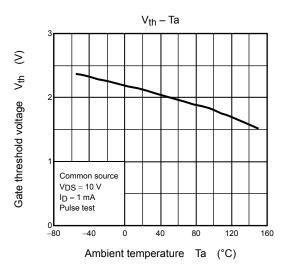


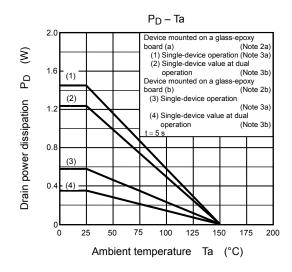


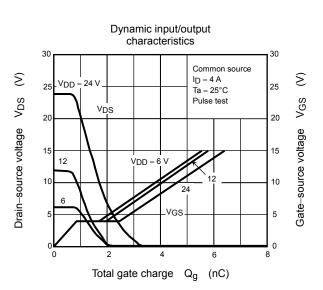


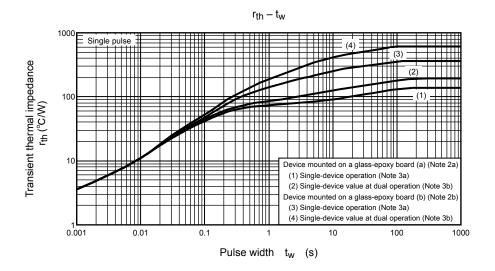


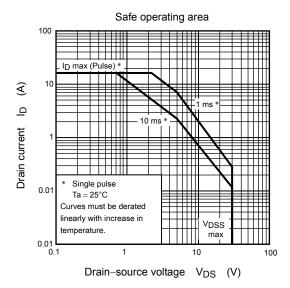












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